

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/584,802	BRENNVALL ET AL.	
Examiner		Art Unit		Page 1 of 1
NAISHADH N. DESAI		2834		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,130,334 A	04-1964	MARIAN NOWAK KAZIMIERZ	310/35
*	B	US-3,707,924 A	01-1973	Barthalon et al.	104/290
*	C	US-4,067,667 A	01-1978	White, Harlan Vernon	417/418
*	D	US-4,395,649 A	07-1983	Thome et al.	310/15
*	E	US-2001/0015580 A1	08-2001	Sato et al.	310/12
*	F	US-6,326,706 B1	12-2001	Zhang, Wei-Min	310/12
*	G	US-2003/0048016 A1	03-2003	Yeh, Show-Way	310/112
*	H	US-2003/0047900 A1	03-2003	Acker et al.	280/124.162
*	I	US-6,572,074 B2	06-2003	Yang et al.	251/54
*	J	US-2003/0234012 A1	12-2003	Bosteels, Dominique	123/670
*	K	US-2007/0040454 A1	02-2007	Freudenberger et al.	310/012
*	L	US-7,184,254 B2	02-2007	Dimanstein, Isaac	361/187
*	M	US-2007/0152512 A1	07-2007	Tian et al.	310/012

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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